



























## Exams for group M18-406

Mon, 16 Dec	16:15 — 17:50	TEST	Law and Economics of Scientific Projects and Units  Nurahov N.N.  B-208
Mon, 23 Dec	10:15 — 11:50	ATT	Computer Technology: Electronic Design Automation (Eda)  Kalashnikov O.A.  V-315
Mon, 23 Dec	12:00 — 15:00	TEST	Legal and International Aspects of Nonproliferation and Nuclear Materials Safety.  Krasnoborodko A.A., Glebov V.B., Kulikov E.G.  402
Mon, 23 Dec	15:00 — 18:00	TEST	Principles of Nuclear Technologies  Apse V.A.  402
Tue, 24 Dec	10:15 — 11:50	ATT	Elements of Fault-tolerant Devices  Stenin V.Y.  V-315
Wed, 25 Dec	13:35 — 15:15	ATT	Electronic Systems Design  Boychenko D.V.  V-306
Wed, 25 Dec	15:20 — 17:00	TEST	Computer Technology  Krasavin A.V.  V-115
Thu, 26 Dec	12:45 — 14:20	TEST	Practical Training (Research Work)  Barbashov V.M.  dep.3
Thu, 26 Dec	14:30 — 16:05	ATT	Principles of Nuclear Electronics  Atkin E.V.  V-315
Fri, 10 Jan	09:00 — 13:00	EXAM	Electronic Systems Design  Boychenko D.V.  V-306
Tue, 14 Jan	09:00 — 13:00	EXAM	Computer Technology: Electronic Design Automation (Eda)  Kalashnikov O.A.  V-315
Mon, 20 Jan	09:00 — 13:00	EXAM	Principles of Nuclear Electronics  Atkin E.V.  V-315
Fri, 24 Jan	09:00 — 13:00	EXAM	Elements of Fault-tolerant Devices  Stenin V.Y.  V-315